# SN54AS867, SN54AS869 <br> SN74ALS867A, SN74ALS869, SN74AS867, SN74AS869 SYNCHRONOUS 8-BIT UP/DOWN COUNTERS <br> SDAS115C - DECEMBER 1982 - REVISED JANUARY 1995 

- Fully Programmable With Synchronous Counting and Loading
- SN74ALS867A and 'AS867 Have Asynchronous Clear; SN74ALS869 and 'AS869 Have Synchronous Clear
- Fully Independent Clock Circuit Simplifies Use
- Ripple-Carry Output for n-Bit Cascading
- Package Options Include Plastic Small-Outline (DW) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (NT) and Ceramic (JT) 300-mil DIPs


## description

These synchronous, presettable, 8 -bit up/down counters feature internal-carry look-ahead circuitry for cascading in high-speed counting applications. Synchronous operation is provided by having all flip-flops clocked simultaneously so that the outputs change coincidentally with each other when so instructed by the count-enable (ENP, ENT) inputs and internal gating. This mode of operation eliminates the output counting spikes normally associated with asynchronous (rippleclock) counters. A buffered clock (CLK) input triggers the eight flip-flops on the rising (positivegoing) edge of the clock waveform.

These counters are fully programmable; they may be preset to any number between 0 and 255 . The load-input circuitry allows parallel loading of the cascaded counters. Because loading is synchronous, selecting the load mode disables the counter and causes the outputs to agree with the data inputs after the next clock pulse.

SN54AS867, SN54AS869 . . . JT PACKAGE SN74ALS867A, SN74ALS869, SN74AS867, SN74AS869 . . . DW OR NT PACKAGE (TOP VIEW)


SN54AS867, SN54AS869 . . . FK PACKAGE (TOP VIEW)


NC - No internal connection

The carry look-ahead circuitry provides for cascading counters for $n$-bit synchronous applications without additional gating. Two count-enable ( $\overline{\mathrm{ENP}}$ and $\overline{\mathrm{ENT}}$ ) inputs and a ripple-carry ( $\overline{\mathrm{RCO}}$ ) output are instrumental in accomplishing this function. Both ENP and ENT must be low to count. The direction of the count is determined by the levels of the select (S0, S1) inputs as shown in the function table. ENT is fed forward to enable $\overline{\mathrm{RCO}}$. $\overline{\mathrm{RCO}}$ thus enabled produces a low-level pulse while the count is zero (all outputs low) counting down or 255 counting up (all outputs high). This low-level overflow-carry pulse can be used to enable successive cascaded stages. Transitions at ENP and ENT are allowed regardless of the level of CLK. All inputs are diode clamped to minimize transmission-line effects, thereby simplifying system design.
These counters feature a fully independent clock circuit. With the exception of the asynchronous clear on the SN74ALS867A and 'AS867, changes at S0 and S1 that modify the operating mode have no effect on the Q outputs until clocking occurs. For the 'AS867 and 'AS869, any time ENP and/or ENT is taken high, $\overline{\mathrm{RCO}}$ either goes or remains high. For the SN74ALS867A and SN74ALS869, any time ENT is taken high, $\overline{\text { RCO }}$ either goes or remains high. The function of the counter (whether enabled, disabled, loading, or counting) is dictated solely by the conditions meeting the stable setup and hold times.

## SN54AS867, SN54AS869

SN74ALS867A, SN74ALS869, SN74AS867, SN74AS869
SYNCHRONOUS 8-BIT UP/DOWN COUNTERS
SDAS115C - DECEMBER 1982 - REVISED JANUARY 1995

## description (continued)

The SN54AS867 and SN54AS869 are characterized for operation over the full military temperature range of $-55^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$. The SN74ALS867A, SN74ALS869, SN74AS867, and SN74AS869 are characterized for operation from $0^{\circ} \mathrm{C}$ to $70^{\circ} \mathrm{C}$.

| FUNCTION TABLE |  |
| :---: | :---: |
| S1 S0 FUNCTION <br> L L Clear <br> L H Count down <br> H L Load <br> H H Count up |  |

## logic symbols $\dagger$


† These symbols are in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.
Pin numbers shown are for the DW, JT, and NT packages.

## logic symbols (continued) $\dagger$


† These symbols are in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.
Pin numbers shown are for the DW, JT, and NT packages.
logic diagram (positive logic)


Pin numbers shown are for the DW, JT, and NT packages.
'AS867, 'AS869


Pin numbers shown are for the DW, JT, and NT packages.

## typical clear, preset, count, and inhibit sequences

The following sequence is illustrated below:

1. Clear outputs to zero (SN74ALS867A and 'AS867 are asynchronous; SN74ALS869 and 'AS869 are synchronous.)
2. Preset to binary 252
3. Count up to $253,254,255,0,1$, and 2
4. Count down to $1,0,255,254,253$, and 252
5. Inhibit

$\dagger \overline{\mathrm{ENT}}$ and $\overline{\mathrm{ENP}}$ both must be low for counting to occur.

## absolute maximum ratings over operating free-air temperature range (unless otherwise noted) $\dagger$

Supply voltage, $\mathrm{V}_{\mathrm{CC}}$. . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 7 V
Input voltage, $\mathrm{V}_{\text {I }}$. . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 7 V
Operating free-air temperature range, $\mathrm{T}_{\mathrm{A}}$ : SN74ALS867A . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . $0^{\circ} \mathrm{C}$ to $70^{\circ} \mathrm{C}$
Storage temperature range
$-65^{\circ} \mathrm{C}$ to $150^{\circ} \mathrm{C}$
$\dagger$ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
recommended operating conditions

|  |  |  |  | 4ALS86 |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | MIN | NOM | MAX |  |
| $\mathrm{V}_{\mathrm{CC}}$ | Supply voltage |  | 4.5 | 5 | 5.5 | V |
| $\mathrm{V}_{\text {IH }}$ | High-level input voltage |  | 2 |  |  | V |
| VIL | Low-level input voltage |  |  |  | 0.8 | V |
| IOH | High-level output current |  |  |  | -0.4 | mA |
| IOL | Low-level output current |  |  |  | 8 | mA |
| $\mathrm{f}_{\text {clock }}$ | Clock frequency |  | 0 |  | 35 | MHz |
| $\mathrm{t}_{\text {w }}$ (clock) | Pulse duration, CLK high or low |  | 14 |  |  | ns |
| $\mathrm{t}_{\mathrm{w}}$ (clear) | Pulse duration of clear pulse, S0 and S1 low |  | 10 |  |  | ns |
|  |  | Data inputs A-H | 10 |  |  |  |
|  |  | $\overline{\mathrm{ENP}}$ or ENT | 15 |  |  |  |
| ${ }_{\text {tsu }}$ | Setup time before CLK $\uparrow$ | S0 low and S1 high (load) | 12 |  |  | ns |
|  |  | S0 high and S1 low (count down) | 12 |  |  |  |
|  |  | S0 and S1 high (count up) | 12 |  |  |  |
|  |  | S0 high after S1 $\uparrow$ or S1 high after S0 $\uparrow$ | 3 |  |  | ns |
|  | Hold time after CLK | Data inputs A-H | 0 |  |  | ns |
| $\mathrm{T}_{\text {A }}$ | Operating free-air temperature |  | 0 |  | 70 | ${ }^{\circ} \mathrm{C}$ |

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | TEST CONDITIONS |  | SN74ALS867A |  |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | MIN | TYP $\ddagger$ | MAX |  |
| $\mathrm{V}_{\text {IK }}$ | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$, | $\mathrm{I}_{\mathrm{I}}=-18 \mathrm{~mA}$ |  |  | -1.2 | V |
| $\mathrm{V}_{\mathrm{OH}}$ | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$ to 5.5 V , | $\mathrm{I} \mathrm{OH}=-0.4 \mathrm{~mA}$ | $\mathrm{V}_{\mathrm{CC}}-2$ |  |  | V |
| VOL | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$ | $\mathrm{I} \mathrm{OL}=4 \mathrm{~mA}$ |  | 0.25 | 0.4 | V |
|  |  | $\mathrm{IOL}=8 \mathrm{~mA}$ |  | 0.35 | 0.5 |  |
| 1 | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{1}=7 \mathrm{~V}$ |  |  | 0.1 | mA |
| 1 IH | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{1}=2.7 \mathrm{~V}$ |  |  | 20 | $\mu \mathrm{A}$ |
| IIL | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{1}=0.4 \mathrm{~V}$ |  |  | -0.2 | mA |
| 10 § | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{\mathrm{O}}=2.25 \mathrm{~V}$ | -30 |  | -112 | mA |
| ICC | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$ |  |  | 28 | 45 | mA |

[^0]switching characteristics (see Figure 1)

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | $\begin{aligned} & \mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V} \text { to } 5.5 \mathrm{~V}, \\ & \mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}, \\ & \mathrm{R}_{\mathrm{L}}=500 \Omega, \\ & \mathrm{~T}_{\mathrm{A}}=\operatorname{MIN} \text { to MAXt } \\ & \hline \end{aligned}$ |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | SN74ALS867A |  |  |
|  |  |  | MIN | MAX |  |
| $f_{\text {max }}$ |  |  | 35 |  | MHz |
| tPLH | CLK | $\overline{\mathrm{RCO}}$ | 4 | 14 | ns |
| tPHL |  |  | 4 | 14 |  |
| tPLH | CLK | Any Q | 3 | 16 | ns |
| tPHL |  |  | 3 | 16 |  |
| tPLH | $\overline{\text { ENT }}$ | $\overline{\mathrm{RCO}}$ | 3 | 14 | ns |
| tPHL |  |  | 2 | 9 |  |
| tPHL | S0 or S1 (clear mode) | Any Q | 8 | 26 | ns |
| tPLH | S0 or S1 (count up/down) | $\overline{\mathrm{RCO}}$ | 4 | 16 | ns |
| tPHL |  |  | 4 | 16 |  |
| tPLH | S0 or S1 (clear mode) | $\overline{\mathrm{RCO}}$ | 4 | 16 | ns |

$\dagger$ For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

## absolute maximum ratings over operating free-air temperature range (unless otherwise noted) $\dagger$



Operating free-air temperature range, $\mathrm{T}_{\mathrm{A}}$ : SN74ALS869 ..................................... $0^{\circ} \mathrm{C}$ to $70^{\circ} \mathrm{C}$
Storage temperature range
$-65^{\circ} \mathrm{C}$ to $150^{\circ} \mathrm{C}$
$\dagger$ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
recommended operating conditions

|  |  |  |  | 4ALS |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | MIN | NOM | MAX | UNIT |
| $\mathrm{V}_{\mathrm{CC}}$ | Supply voltage |  | 4.5 | 5 | 5.5 | V |
| $\mathrm{V}_{\text {IH }}$ | High-level input voltage |  | 2 |  |  | V |
| VIL | Low-level input voltage |  |  |  | 0.8 | V |
| ${ }^{\text {IOH }}$ | High-level output current |  |  |  | -0.4 | mA |
| IOL | Low-level output current |  |  |  | 8 | mA |
| $\mathrm{f}_{\text {clock }}$ | Clock frequency |  | 0 |  | 35 | MHz |
| $\mathrm{t}_{\text {w }}$ (clock) | Pulse duration, CLK high or low |  | 14 |  |  | ns |
|  |  | Data inputs A-H | 10 |  |  |  |
|  |  | $\overline{\mathrm{ENP}}$ or ENT | 15 |  |  |  |
|  |  | S0 and S1 low (clear) | 13 |  |  |  |
| tsu | up time before CLK | S0 low and S1 high (load) | 13 |  |  |  |
|  |  | S0 high and S1 low (count down) | 13 |  |  |  |
|  |  | S0 and S1 high (count up) | 13 |  |  |  |
|  | Hold time after CLK $\uparrow$ | S0 high after S1 $\uparrow$ or S1 high after S0 $\uparrow$ | 3 |  |  |  |
| th | Hold time after CLK | Data inputs A-H | 0 |  |  |  |
| TA | Operating free-air temperature |  | 0 |  | 70 | ${ }^{\circ} \mathrm{C}$ |

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | TEST CONDITIONS |  | SN74ALS869 |  |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | MIN | TYP $\ddagger$ | MAX |  |
| $\mathrm{V}_{\mathrm{IK}}$ | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$, | $\mathrm{I}_{\mathrm{I}}=-18 \mathrm{~mA}$ |  |  | -1.2 | V |
| $\mathrm{V}_{\mathrm{OH}}$ | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$ to 5.5 V , | $\mathrm{I} \mathrm{OH}=-0.4 \mathrm{~mA}$ | $\mathrm{V}_{\mathrm{CC}}-2$ |  |  | V |
| VOL | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$ | $\mathrm{I} \mathrm{OL}=4 \mathrm{~mA}$ |  | 0.25 | 0.4 | V |
|  |  | $\mathrm{IOL}=8 \mathrm{~mA}$ |  | 0.35 | 0.5 |  |
| 1 | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{\mathrm{I}}=7 \mathrm{~V}$ |  |  | 0.1 | mA |
| IIH | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{1}=2.7 \mathrm{~V}$ |  |  | 20 | $\mu \mathrm{A}$ |
| IIL | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{1}=0.4 \mathrm{~V}$ |  |  | -0.2 | mA |
| 10 § | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{\mathrm{O}}=2.25 \mathrm{~V}$ | -30 |  | -112 | mA |
| ICC | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$ |  |  | 28 | 45 | mA |

[^1]switching characteristics (see Figure 1)

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | $\begin{aligned} & \mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V} \text { to } 5.5 \mathrm{~V}, \\ & \mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}, \\ & \mathrm{R}_{\mathrm{L}}=500 \Omega, \\ & \mathrm{~T}_{\mathrm{A}}=\operatorname{MIN} \text { to MAXt } \\ & \hline \end{aligned}$ |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | SN74ALS869 |  |  |
|  |  |  | MIN | MAX |  |
| $\mathrm{f}_{\text {max }}$ |  |  | 35 |  | MHz |
| tPLH | CLK | $\overline{\mathrm{RCO}}$ | 4 | 14 | ns |
| tPHL |  |  | 4 | 14 |  |
| tPLH | CLK | Any Q | 3 | 16 | ns |
| tPHL |  |  | 3 | 16 |  |
| tPLH | $\overline{\text { ENT }}$ | $\overline{\mathrm{RCO}}$ | 3 | 14 | ns |
| tPHL |  |  | 2 | 9 |  |
| tPLH | S1 <br> (count up/down) | $\overline{\mathrm{RCO}}$ | 4 | 15 | ns |
| tPHL |  |  | 4 | 15 |  |
| tPLH | S0 (clear/load) | $\overline{\mathrm{RCO}}$ | 4 | 16 | ns |
| tPHL |  |  | 4 | 12 |  |

$\dagger$ For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

## absolute maximum ratings over operating free-air temperature range (unless otherwise noted) $\dagger$




SN74AS867
$0^{\circ} \mathrm{C}$ to $70^{\circ} \mathrm{C}$
Storage temperature range
$-65^{\circ} \mathrm{C}$ to $150^{\circ} \mathrm{C}$
$\dagger$ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
recommended operating conditions


* On products compliant to MIL-STD-883, Class B, this parameter is based on characterization data but is not production tested.
electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER |  | TEST CONDITIONS |  | SN54AS867 |  |  | SN74AS867 |  |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | MIN | TYP† | MAX | MIN | TYP $\dagger$ | MAX |  |
| $\mathrm{V}_{\text {IK }}$ |  |  |  | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$, | $\mathrm{I}=-18 \mathrm{~mA}$ |  |  | -1.2 |  |  | -1.2 | V |
| $\mathrm{V}_{\mathrm{OH}}$ |  | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$ to 5.5 V , | $\mathrm{I}^{\mathrm{OH}}=-2 \mathrm{~mA}$ | $\mathrm{V}_{\mathrm{CC}}-$ |  |  | $\mathrm{V}_{\mathrm{CC}}-2$ |  |  | V |
| VOL | $\overline{\mathrm{RCO}}$ | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$ | $\begin{array}{\|l} \hline \mathrm{IOL}=20 \mathrm{~mA}, \\ \mathrm{~V}_{\mathrm{IL}} \text { on } \mathrm{ENT}=0.7 \mathrm{~V} \\ \hline \end{array}$ |  | 0.34 | 0.5 |  |  |  | V |
|  | Other outputs |  | $\mathrm{I} \mathrm{OL}=20 \mathrm{~mA}$ |  |  |  |  | 0.34 | 0.5 |  |
| 1 |  | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{\mathrm{I}}=7 \mathrm{~V}$ |  |  | 0.1 |  |  | 0.1 | mA |
| ${ }^{1} \mathrm{H}$ | ENT | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{\mathrm{I}}=2.7 \mathrm{~V}$ |  |  | 40 |  |  | 40 | $\mu \mathrm{A}$ |
|  | Other inputs |  |  |  |  | 20 |  |  | 20 |  |
| IIL | ENT | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}=0.4 \mathrm{~V}$ |  |  | -4 |  |  | -4 | mA |
|  | Other inputs |  |  |  |  | -2 |  |  | -2 |  |
| $10^{\ddagger}$ |  | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{\mathrm{O}}=2.25 \mathrm{~V}$ | -30 |  | -112 | -30 |  | -112 | mA |
| ICC |  | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$ |  |  | 134 | 195 |  | 134 | 195 | mA |

$\dagger$ All typical values are at $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.
$\ddagger$ The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.

## switching characteristics (see Figure 1)

| PARAMETER | FROM (INPUT) | $\begin{gathered} \text { TO } \\ \text { (OUTPUT) } \end{gathered}$ | $\begin{aligned} & \mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V} \text { to } 5.5 \mathrm{~V}, \\ & \mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}, \\ & \mathrm{R}_{\mathrm{L}}=500 \Omega, \\ & \mathrm{~T}_{\mathrm{A}}=\operatorname{MIN} \text { to MAX§ } \end{aligned}$ |  |  |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | SN54AS867 |  | SN74AS867 |  |  |
|  |  |  | MIN | MAX | MIN | MAX |  |
| $f_{\text {max }}{ }^{*}$ |  |  | 40 |  | 50 |  | MHz |
| tPLH | CLK | $\overline{\mathrm{RCO}}$ | 5 | 31 | 5 | 22 | ns |
| tPHL |  |  | 6 | 19 | 6 | 16 |  |
| tPLH | CLK | Any Q | 3 | 12 | 3 | 11 | ns |
| tPHL |  |  | 4 | 16 | 4 | 15 |  |
| tPLH | $\overline{\text { ENT }}$ | $\overline{\mathrm{RCO}}$ | 3 | 19 | 3 | 10 | ns |
| tPHL |  |  | 5 | 21 | 5 | 17 |  |
| tPLH | $\overline{E N P}$ | $\overline{\mathrm{RCO}}$ | 5 | 16 | 5 | 14 | ns |
| tPHL |  |  | 5 | 21 | 5 | 17 |  |
| tPHL | Clear (S0 or S1 low) | Any Q | 7 | 23 | 7 | 21 | ns |

[^2]
## absolute maximum ratings over operating free-air temperature range (unless otherwise noted) ${ }^{\dagger}$

Supply voltage, $\mathrm{V}_{\mathrm{CC}}$........................................................................................... 7 V


SN74AS869
$0^{\circ} \mathrm{C}$ to $70^{\circ} \mathrm{C}$
Storage temperature range $-65^{\circ} \mathrm{C}$ to $150^{\circ} \mathrm{C}$
$\dagger$ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
recommended operating conditions


[^3]electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER |  | TEST CONDITIONS |  | SN54AS869 |  |  | SN74AS869 |  |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | MIN | TYP $\dagger$ | MAX | MIN | TYP $\dagger$ | MAX |  |
| $\mathrm{V}_{\text {IK }}$ |  |  |  | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$, | $\mathrm{I}=-18 \mathrm{~mA}$ |  |  | -1.2 |  |  | -1.2 | V |
| $\mathrm{V}_{\mathrm{OH}}$ |  | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$ to 5.5 V , | $\mathrm{IOH}=-2 \mathrm{~mA}$ |  |  |  | $\mathrm{V}_{\mathrm{CC}}-2$ |  |  | V |
|  |  | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$, | $\mathrm{IOH}=-2 \mathrm{~mA}$ | $\mathrm{V}_{\mathrm{CC}}-2^{*}$ |  |  |  |  |  |  |
| VOL | $\overline{\text { RCO }}$ | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$ | $\begin{aligned} & \mathrm{IOL}=20 \mathrm{~mA}, \\ & \mathrm{~V}_{\text {IL }} \text { on } \overline{\mathrm{ENT}}=0.7 \mathrm{~V} \end{aligned}$ |  | 0.34 | 0.5 |  |  |  | V |
|  | Other outputs |  | $\mathrm{IOL}=20 \mathrm{~mA}$ |  |  |  |  | 0.34 | 0.5 |  |
| 1 |  | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{\mathrm{I}}=7 \mathrm{~V}$ |  |  | 0.1 |  |  | 0.1 | mA |
| ${ }^{\text {IIH }}$ | ENT | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{\mathrm{I}}=2.7 \mathrm{~V}$ |  |  | 40 |  |  | 40 | $\mu \mathrm{A}$ |
|  | Other inputs |  |  |  |  | 20 |  |  | 20 |  |
| IIL | ENT | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}=0.4 \mathrm{~V}$ |  |  | -4 |  |  | -4 | mA |
|  | Other inputs |  |  |  |  | -2 |  |  | -2 |  |
| $10^{\ddagger}$ |  | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{\mathrm{O}}=2.25 \mathrm{~V}$ | -30 |  | -112 | -30 |  | -112 | mA |
| Icc |  | $\mathrm{V}_{C C}=5.5 \mathrm{~V}$ |  |  | 134 | 195 |  | 134 | 195 | mA |

$\dagger$ All typical values are at $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.
$\ddagger$ The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.
switching characteristics (see Figure 1)

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | $\begin{aligned} & \mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V} \text { to } 5.5 \mathrm{~V}, \\ & \mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}, \\ & \mathrm{R}_{\mathrm{L}}=500 \Omega, \\ & \mathrm{~T}_{\mathrm{A}}=\operatorname{MIN} \text { to MAX§ } \end{aligned}$ |  |  |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | SN54AS869 |  | SN74AS869 |  |  |
|  |  |  | MIN | MAX | MIN | MAX |  |
| ${ }_{\text {max }}{ }^{*}$ |  |  | 40 |  | 45 |  | MHz |
| tPLH | CLK | $\overline{\mathrm{RCO}}$ | 6 | 35 | 6 | 35 | ns |
| tPHL |  |  | 6 | 20 | 6 | 18 |  |
| tPLH | CLK | Any Q | 3 | 12 | 3 | 11 | ns |
| tPHL |  |  | 4 | 16 | 4 | 15 |  |
| tPLH | ENT | $\overline{\mathrm{RCO}}$ | 3 | 25 | 3 | 15 | ns |
| tPHL |  |  | 6 | 21 | 6 | 17 |  |
| tPLH | $\overline{\text { ENP }}$ | $\overline{\mathrm{RCO}}$ | 5 | 27 | 5 | 19 | ns |
| tPHL |  |  | 6 | 21 | 6 | 18 |  |

[^4]
## PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



voltage waveforms SETUP AND HOLD TIMES

voltage waveforms PULSE DURATIONS


ENABLE AND DISABLE TIMES, 3-STATE OUTPUTS


NOTES: A. $C_{L}$ includes probe and jig capacitance.
B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
D. All input pulses have the following characteristics: $\mathrm{PRR} \leq 1 \mathrm{MHz}, \mathrm{t}_{r}=\mathrm{t}_{\mathrm{f}}=2 \mathrm{~ns}$, duty cycle $=50 \%$.
E. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms

## PACKAGING INFORMATION

| Orderable Device | Status ${ }^{(1)}$ | Package Type | Package Drawing | Pins | Package Qty | $\text { Eco Plan }{ }^{(2)}$ | Lead/Ball Finish | MSL Peak Temp ${ }^{(3)}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 5962-89526013A | ACTIVE | LCCC | FK | 28 | 1 | TBD | POST-PLATE | N / A for Pkg Type |
| 5962-8952601KA | ACTIVE | CFP | W | 24 | 1 | TBD | A42 | N/ A for Pkg Type |
| 5962-8952601LA | ACTIVE | CDIP | JT | 24 | 1 | TBD | A42 SNPB | N / A for Pkg Type |
| 5962-89668013A | ACTIVE | LCCC | FK | 28 | 1 | TBD | POST-PLATE | N/ A for Pkg Type |
| 5962-8966801KA | ACTIVE | CFP | W | 24 | 1 | TBD | A42 | N/ A for Pkg Type |
| 5962-8966801LA | ACTIVE | CDIP | JT | 24 | 1 | TBD | A42 SNPB | N/ A for Pkg Type |
| SN54AS867JT | ACTIVE | CDIP | JT | 24 | 1 | TBD | A42 SNPB | N / A for Pkg Type |
| SN54AS869JT | ACTIVE | CDIP | JT | 24 | 1 | TBD | A42 SNPB | N / A for Pkg Type |
| SN74ALS867ADW | ACTIVE | SOIC | DW | 24 | 25 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| SN74ALS867ADWE4 | ACTIVE | SOIC | DW | 24 | 25 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| SN74ALS867ADWG4 | ACTIVE | SOIC | DW | 24 | 25 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br}) \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| SN74ALS867ADWR | ACTIVE | SOIC | DW | 24 | 2000 | Green (RoHS \& no $\mathrm{Sb} / \mathrm{Br}$ ) | CU NIPDAU | Level-1-260C-UNLIM |
| SN74ALS867ADWRE4 | ACTIVE | SOIC | DW | 24 | 2000 | $\begin{gathered} \hline \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \\ \hline \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| SN74ALS867ADWRG4 | ACTIVE | SOIC | DW | 24 | 2000 | $\begin{gathered} \hline \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \\ \hline \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| SN74ALS867ANT | ACTIVE | PDIP | NT | 24 | 15 | Pb-Free (RoHS) | CU NIPDAU | N/ A for Pkg Type |
| SN74ALS867ANTE4 | ACTIVE | PDIP | NT | 24 | 15 | Pb-Free (RoHS) | CU NIPDAU | N/ A for Pkg Type |
| SN74ALS869DW | ACTIVE | SOIC | DW | 24 | 25 | Green (RoHS \& no $\mathrm{Sb} / \mathrm{Br}$ ) | CU NIPDAU | Level-1-260C-UNLIM |
| SN74ALS869DWE4 | ACTIVE | SOIC | DW | 24 | 25 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \\ \hline \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| SN74ALS869DWG4 | ACTIVE | SOIC | DW | 24 | 25 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \\ \hline \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| SN74ALS869DWR | ACTIVE | SOIC | DW | 24 | 2000 | $\begin{gathered} \hline \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \\ \hline \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| SN74ALS869DWRE4 | ACTIVE | SOIC | DW | 24 | 2000 | Green (RoHS \& no $\mathrm{Sb} / \mathrm{Br})$ | CU NIPDAU | Level-1-260C-UNLIM |
| SN74ALS869DWRG4 | ACTIVE | SOIC | DW | 24 | 2000 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| SN74ALS869NT | ACTIVE | PDIP | NT | 24 | 15 | Pb-Free (RoHS) | CU NIPDAU | N/ A for Pkg Type |
| SN74ALS869NTE4 | ACTIVE | PDIP | NT | 24 | 15 | Pb-Free (RoHS) | CU NIPDAU | N/A for Pkg Type |
| SN74AS867DW | ACTIVE | SOIC | DW | 24 | 25 | Green (RoHS \& no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| SN74AS867DWE4 | ACTIVE | SOIC | DW | 24 | 25 | $\begin{gathered} \hline \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br}) \\ \hline \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| SN74AS867DWG4 | ACTIVE | SOIC | DW | 24 | 25 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| SN74AS867DWR | ACTIVE | SOIC | DW | 24 | 2000 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |


| Orderable Device | Status ${ }^{(1)}$ | Package Type | Package Drawing |  | Package Qty | Eco Plan ${ }^{(2)}$ | Lead/Ball Finish | MSL Peak Temp ${ }^{(3)}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| SN74AS867DWRE4 | ACTIVE | SOIC | DW | 24 | 2000 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| SN74AS867DWRG4 | ACTIVE | SOIC | DW | 24 | 2000 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| SN74AS867NT | ACTIVE | PDIP | NT | 24 | 15 | Pb-Free (RoHS) | CU NIPDAU | N/ A for Pkg Type |
| SN74AS867NT3 | OBSOLETE | PDIP | NT | 24 |  | TBD | Call TI | Call TI |
| SN74AS867NTE4 | ACTIVE | PDIP | NT | 24 | 15 | Pb-Free (RoHS) | CU NIPDAU | N/A for Pkg Type |
| SN74AS869DW | ACTIVE | SOIC | DW | 24 | 25 | Green (RoHS \& no $\mathrm{Sb} / \mathrm{Br}$ ) | CU NIPDAU | Level-1-260C-UNLIM |
| SN74AS869DWE4 | ACTIVE | SOIC | DW | 24 | 25 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \\ \hline \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| SN74AS869DWG4 | ACTIVE | SOIC | DW | 24 | 25 | Green (RoHS \& no $\mathrm{Sb} / \mathrm{Br}$ ) | CU NIPDAU | Level-1-260C-UNLIM |
| SN74AS869DWR | ACTIVE | SOIC | DW | 24 | 2000 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| SN74AS869DWRE4 | ACTIVE | SOIC | DW | 24 | 2000 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| SN74AS869DWRG4 | ACTIVE | SOIC | DW | 24 | 2000 | $\begin{gathered} \text { Green (RoHS \& } \\ \text { no } \mathrm{Sb} / \mathrm{Br} \text { ) } \end{gathered}$ | CU NIPDAU | Level-1-260C-UNLIM |
| SN74AS869NT | ACTIVE | PDIP | NT | 24 | 15 | Pb-Free (RoHS) | CU NIPDAU | N/ A for Pkg Type |
| SN74AS869NT3 | OBSOLETE | PDIP | NT | 24 |  | TBD | Call TI | Call TI |
| SN74AS869NTE4 | ACTIVE | PDIP | NT | 24 | 15 | Pb-Free (RoHS) | CU NIPDAU | N/A for Pkg Type |
| SNJ54AS867FK | ACTIVE | LCCC | FK | 28 | 1 | TBD | POST-PLATE | N / A for Pkg Type |
| SNJ54AS867JT | ACTIVE | CDIP | JT | 24 | 1 | TBD | A42 SNPB | N/ A for Pkg Type |
| SNJ54AS867W | ACTIVE | CFP | W | 24 | 1 | TBD | A42 | N/ A for Pkg Type |
| SNJ54AS869FK | ACTIVE | LCCC | FK | 28 | 1 | TBD | POST-PLATE | N/ A for Pkg Type |
| SNJ54AS869JT | ACTIVE | CDIP | JT | 24 | 1 | TBD | A42 SNPB | N/ A for Pkg Type |
| SNJ54AS869W | ACTIVE | CFP | W | 24 | 1 | TBD | A42 | N / A for Pkg Type |

${ }^{(1)}$ The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but Tl does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.

[^5]${ }^{(3)}$ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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## TAPE AND REEL BOX INFORMATION



TAPE DIMENSIONS


| A0 | Dimension designed to accommodate the component width |
| :--- | :--- |
| B0 | Dimension designed to accommodate the component length |
| K0 | Dimension designed to accommodate the component thickness |
| W | Overall width of the carrier tape |
| P1 | Pitch between successive cavity centers |

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE


| Device | Package | Pins | Site | Reel <br> Diameter <br> $(\mathbf{m m})$ | Reel <br> Width <br> $(\mathbf{m m})$ | A0 (mm) | B0 (mm) | K0 (mm) | P1 <br> $(\mathbf{m m})$ | W <br> $(\mathbf{m m})$ | Pin1 <br> Quadrant |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| SN74ALS867ADWR | DW | 24 | SITE 60 | 330 | 24 | 10.75 | 15.7 | 2.7 | 12 | 24 | Q1 |
| SN74ALS869DWR | DW | 24 | SITE 60 | 330 | 24 | 10.75 | 15.7 | 2.7 | 12 | 24 | Q1 |
| SN74AS867DWR | DW | 24 | SITE 60 | 330 | 24 | 10.75 | 15.7 | 2.7 | 12 | 24 | Q1 |
| SN74AS869DWR | DW | 24 | SITE 60 | 330 | 24 | 10.75 | 15.7 | 2.7 | 12 | 24 | Q1 |



| Device | Package | Pins | Site | Length (mm) | Width (mm) | Height (mm) |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| SN74ALS867ADWR | DW | 24 | SITE 60 | 346.0 | 346.0 | 41.0 |
| SN74ALS869DWR | DW | 24 | SITE 60 | 346.0 | 346.0 | 41.0 |
| SN74AS867DWR | DW | 24 | SITE 60 | 346.0 | 346.0 | 41.0 |
| SN74AS869DWR | DW | 24 | SITE 60 | 346.0 | 346.0 | 41.0 |



NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. This package can be hermetically sealed with a ceramic lid using glass frit.
D. Index point is provided on cap for terminal identification.
E. Falls within MIL STD 1835 GDIP3-T24, GDIP4-T28, and JEDEC MO-058 AA, MO-058 AB


NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice
C. This package can be hermetically sealed with a ceramic lid using glass frit.
D. Falls within MIL-STD-1835 GDFP2-F24 and JEDEC MO-070AD
E. Index point is provided on cap for terminal identification only.

FK (S-CQCC-N**)


NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. This package can be hermetically sealed with a metal lid.
D. The terminals are gold plated.
E. Falls within JEDEC MS-004


NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.

DW (R-PDSO-G24)

## PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. Body dimensions do not include mold flash or protrusion not to exceed $0.006(0,15)$.
D. Falls within JEDEC MS-013 variation AD.

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[^0]:    $\ddagger$ All typical values are at $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.
    § The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.

[^1]:    $\ddagger$ All typical values are at $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.
    § The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.

[^2]:    * On products compliant to MIL-STD-883, Class B, this parameter is based on characterization data but is not production tested.
    § For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

[^3]:    * On products compliant to MIL-STD-883, Class B, this parameter is based on characterization data but is not production tested.

[^4]:    * On products compliant to MIL-STD-883, Class B, this parameter is based on characterization data but is not production tested.
    § For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

[^5]:    ${ }^{(2)}$ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS \& no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.
    TBD: The $\mathrm{Pb}-\mathrm{Free} / \mathrm{Green}$ conversion plan has not been defined.
    Pb -Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed $0.1 \%$ by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.
    Pb -Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.
    Green (RoHS \& no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine ( Br ) and Antimony (Sb) based flame retardants ( Br or Sb do not exceed $0.1 \%$ by weight in homogeneous material)

